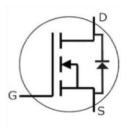


# Wolfspeed SiC Gen 3 MOSFET

### **Description**

This is the Wolfspeed's 3rd generation of high performance silicon carbide MOSFET in a packageless bare die format to be implemented into any custom module design. The high blocking voltage with low on-resistance, high speed switching with low capacitance make this MOSFET ideal for high frequency switching application including solar inverters and EV chargers.





Package Types: Bare Die PN's: CPM3-1200-0021A

#### **Features**

- Enhanced 3rd Generation SiC MOSFET
- High blocking voltage with low on-resistance
- High speed switching with low capacitance
- Fast intrinsic diode with low reverse recovery

### **Applications**

- Motor Drive
- Solar Inverters
- SMPS
- High voltage DC/DC converters

### **Absolute Maximum Ratings**

Stress beyond those listed under absolute maximum ratings may damage the device.

rameter Symbol			Rating	Unit
Drain-Source Voltage, across T <sub>vj</sub>	V <sub>DS(max)</sub>		1200	V
Maximum Gate-Source Voltage, Peak Transient Capability	V <sub>GS(max)</sub>		-8/+19	V
Continuous Drain Current, V <sub>GS</sub> = 15V, assumes die packaged in	lp	$T_c = 25^{\circ}C$	100	
TO-247 package with $R_{th(j-c)}$ < 0.32 K/W		$T_c = 100$ °C	74.5	A
Pulsed Drain Current, tp limited by Tvj(max)	I <sub>D</sub> (pulse)		200	Α
Virtual Junction and Storage Temperature	TvJ, Tstg		-55 to 175	°C
Maximum Processing Temperature, in non-reactive ambient	T <sub>proc</sub>		325	°C

### **Recommended Operating Conditions**

Parameter	Symbol	Rating	Unit
Recommended Operating Gate - Source Voltage	V <sub>G</sub> S(op)	-4/+15	V

# Electrical Characteristics (T<sub>VJ</sub> = 25°C)

Characteristics	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	1200			V	$V_{GS} = 0 \text{ V, } I_D = 100  \mu\text{A}$
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.8	2.5	3.6	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 16.8 mA
			2		V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 16.8 mA, T <sub>VJ</sub> = 175°C
Zero Gate Voltage Drain Current	loss		1	25	μΑ	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V
Gate-Source Leakage Current	Igss		10	100	nA	V <sub>GS</sub> = 15 V, V <sub>DS</sub> = 0 V
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	14.5	21	27	0	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 61 A
			38		mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 61 A, T <sub>VJ</sub> = 175°C
Transconductance	gfs		35		- S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 61 A
			33			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 61 A, T <sub>VJ</sub> = 175°C
Input Capacitance	Ciss		4818			V 0.4 4 1000 V
Output Capacitance	Coss		180		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ f = 100  kHz
Reverse Transfer Capacitance	Crss		12		]	V <sub>AC</sub> = 25 mV
Coss Stored Energy	E <sub>oss</sub>		99		μJ	V <sub>DS</sub> = 1000 V, f = 100 kHz
Internal Gate Resistance	R <sub>G(int)</sub>		3.3		Ω	f = 100 kHz, V <sub>AC</sub> = 25 mV
Gate to Source Charge	Qgs		49			V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -4 V/15 V
Gate to Drain Charge	Q <sub>gd</sub>		50		nC I <sub>DS</sub>	I <sub>DS</sub> = 61 A
Total Gate Charge	Qg		162			Per IEC60747-8-4 pg 21

### Reverse Diode Characteristics (T<sub>VJ</sub> = 25 °C)

Characteristics	Symbol	Тур.	Max.	Unit	Test Conditions	
Diode Forward Voltage	VsD	4.6		V	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 30.5 A	
		4.2		V	$V_{GS} = -4 \text{ V}, I_{SD} = 30.5 \text{ A}, T_{VJ} = 175 ^{\circ}\text{C}$	
Reverse Recovery Time	trr	34		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 61 \text{ A}, V_R = 800 \text{ V}$ $dif/dt = 2600 \text{ A}/\mu\text{s}, T_{VJ} = 175 \text{ °C}$	
Reverse Recovery Charge	Qrr	928		nC		
Peak Reverse Recovery Current	Irrm	42		А		

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

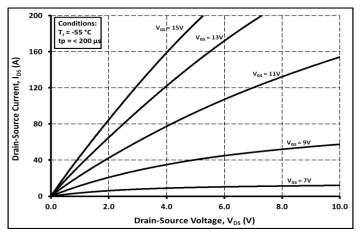


Figure 1.

Output Characteristics T<sub>vj</sub> = -55 °C

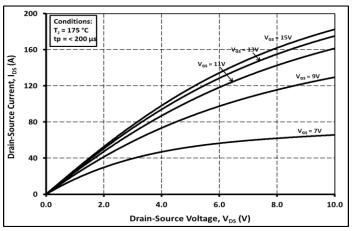


Figure 3.

Output Characteristics T<sub>vj</sub> = 175 °C

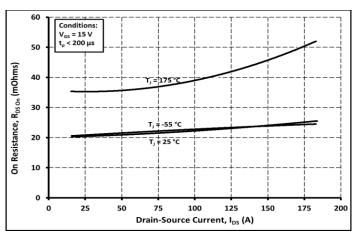


Figure 5.

On-Resistance vs. Drain Current For Various Temperatures

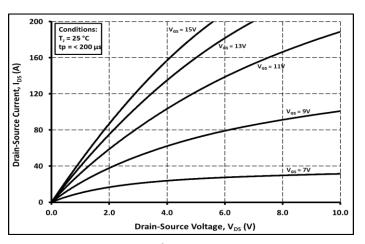


Figure 2.

Output Characteristics T<sub>vj</sub> = 25 °C

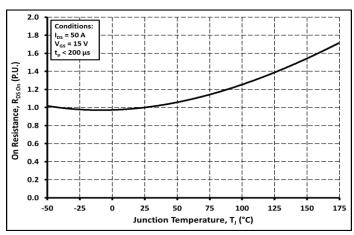


Figure 4.

Normalized On-Resistance vs. Temperature

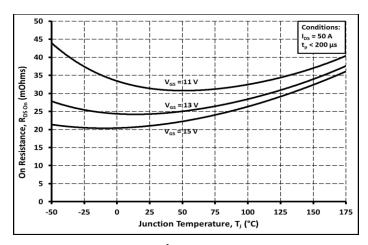


Figure 6.

On-Resistance vs. Temperature For Various Gate Voltages

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

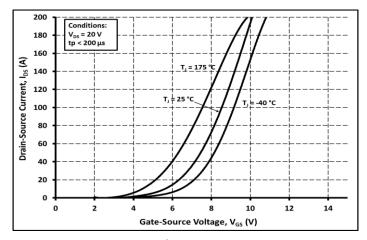


Figure 7.

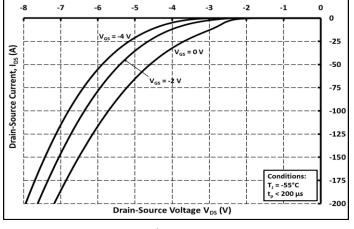


Figure 8.

Body Diode Characteristic at T<sub>vj</sub> = -55 °C

Transfer Characteristic For Various Junction Temperatures

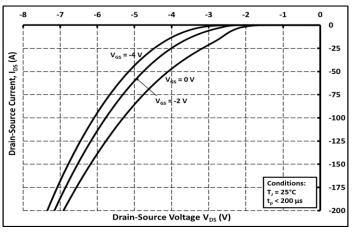


Figure 9.

-7 0 0 -25 € \_DS -50 Drain-Source Current, -100 -125 -150

Drain-Source Voltage V<sub>DS</sub> (V) Figure 10.

Conditions:

T<sub>j</sub> = 175°C t<sub>p</sub> < 200 μs

-175

Body Diode Characteristic at T<sub>vj</sub> = 25 °C

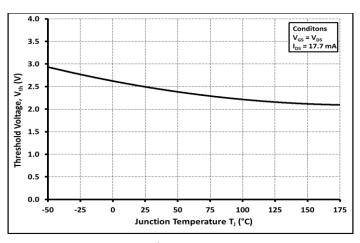


Figure 11.

Threshold Voltage vs. Temperature

Body Diode Characteristic at T<sub>vj</sub> = 175 °C

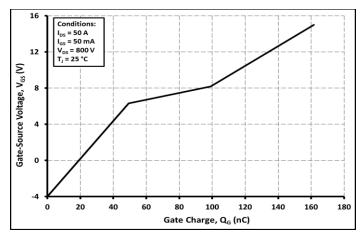


Figure 12.

**Gate Charge Characteristics** 

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

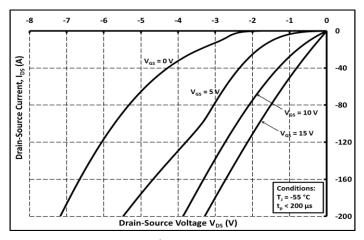


Figure 13.

3rd Quadrant Characteristic at T<sub>vj</sub> = -55 °C

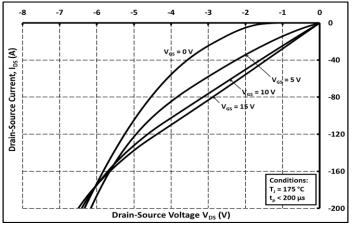


Figure 15.

3rd Quadrant Characteristic at T<sub>vj</sub> = 175 °C

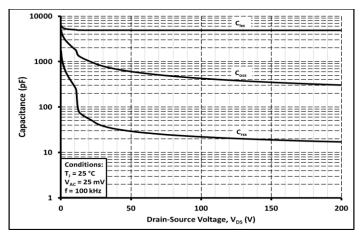


Figure 17.

Capacitances vs. Drain-Source Voltage (0-200V)

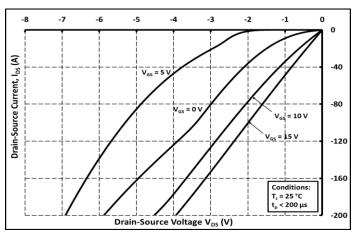


Figure 14.

3rd Quadrant Characteristic at T<sub>vj</sub> = 25 °C

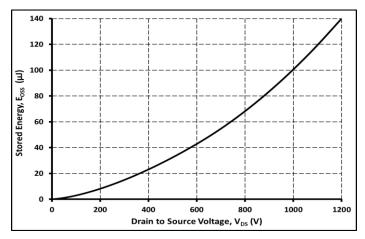


Figure 16.

**Output Capacitor Stored Energy** 

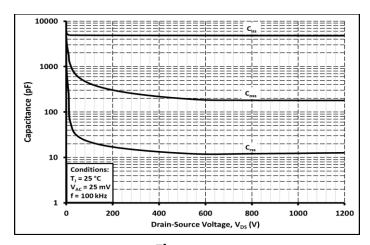


Figure 18.

Capacitances vs. Drain-Source Voltage (0-1200V)

# **Product Ordering Information**

Order Number	Description	Package
CPM3-1200-0021A-FY6	SIC MOSFET G3 IND 1200V/21mO UV MLT	Bare Die Product
CPM3-1200-0021A-GQ8	SIC MOSFET G3 IND 1200V/21mO UV MVF	Bare Die Product

## **Revision History**

The information in this document is subject to change without notice.

<b>Revision History</b>	Date of Change	Brief Summary
-	04/04/2019	Initial Release
1	01/09/2020	<ul> <li>Removed test conditions and note section from the Maximum Ratings Table</li> <li>Updated description for all the parameters in the Maximum Ratings Table</li> <li>Updated footnotes</li> <li>Temperature note removed and embedded into every test condition</li> <li>Updated test conditions for gate threshold voltage, drainsource on-state resistance, transconductance, gate to source charge, gate to drain charge, total gate charge, diode forward voltage, reverse recovery time, reverse recovery charge and peak reverse recovery current</li> <li>Updated typical values for continuous drain current, zero gate voltage drain current, gate-source leakage current, drain-source on-state resistance, transconductance, input capacitance, reverse transfer capacitance, Coss stored energy, gate to source charge, gate to drain charge, total gate charge, reverse recovery time and reverse recovery charge</li> <li>All junction temperatures changed to virtual junction temperatures</li> <li>All graphs updated to reflect the most recent test data</li> </ul>
2	7/30/2023	Document format updated

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#### **REACh Compliance**

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact your Wolfspeed representative to ensure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information is also available upon request.

#### **Contact info:**

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